Application/Control No. Applicant(s)/Patent Under Reexamination 10/790,785 MITAMURA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Patrick J. Lee 2878 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,981,941 11-1999 Takata et al. 250/231.16 US-6,713,756 B2 03-2004 Yamamoto et al. 250/231.13 В US-С US-D Ε US-US-F US-G US-Н US-1 US-Κ US-US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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